Search Notes			

•	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/603,361	CHAN ET AL.	
	Examiner	Art Unit	_
	Ron E. Pompey	2812	

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Class	Subclass	Date	Examiner
			
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARC	DTES H STRATEGY	·)
	DATE	EXMR
updated search mailed 6-29-06 、	12/5/2006	RP